Search	Notes	(continued	I)

Application/Control No.	Applicant(s)/Patent under Reexamination
09/972,962	HAYASHINO ET AL.
Examiner	Art Unit
Anh-Vu H. Ly	2616

	SEAR	CHED	
Class	Subclass	Date	Examiner
•			
	:		
	<u> </u>		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date [*]	Examiner	
	ce search printout	4/29/2006	AVL	

SEARCH NOT (INCLUDING SEARCH	'ES STRATEGY)
	DATE	EXMR
· · · · · · · · · · · · · · · · · · ·		
	:	
	!	
•		
-	,	